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10/748,562

Examiner

Wen-Ying P. Chen

Applicant(s)/Patent under Reexamination

CRAWFORD ET AL.

Art Unit

2871

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INTERFERENCE SEARCHED					
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Key word and citations search on EAST	6/14/2005	WPC
Consulted Primary Examiner Andrew Schechter on subclasses 123-136 plus key word search.	6/14/2005	wpc
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